

# **N-Channel Power MOSFET**

30V, 78A, 3.8mΩ

## **FEATURES**

- Low R<sub>DS(ON)</sub> to minimize conductive losses
- Low gate charge for fast power switching
- 100% UIS and R<sub>q</sub> tested
- Compliant to RoHS directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

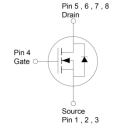
KEY PERFORMANCE PARAMETERS				
PARAMETER		VALUE	UNIT	
$V_{DS}$		30	V	
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V	3.8		
(max)	$V_{GS} = 4.5V$	5.5	mΩ	
$Q_g$		24	nC	

## **APPLICATIONS**

- DC-DC Converters
- Battery Power Management
- ORing FET/Load Switching







Note: MSL 1 (Moisture Sensitivity Level) per J-STD-020

ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25°C unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		$V_{DS}$	30	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain Current (Note 1)	$T_C = 25^{\circ}C$	l <sub>D</sub>	78	^	
	$T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$		19	A	
Pulsed Drain Current		I <sub>DM</sub>	312	Α	
Single Pulse Avalanche Current (Note 2)		I <sub>AS</sub>	26	А	
Single Pulse Avalanche Energy (Note 2)		E <sub>AS</sub>	101	mJ	
Total Power Dissipation	$T_C = 25^{\circ}C$	P <sub>D</sub>	39	14/	
	T <sub>C</sub> = 125°C		7.8	W	
Total Power Dissipation	$T_A = 25$ °C	Б	2.4	10/	
	T <sub>A</sub> = 125°C	P <sub>D</sub>	0.5	W	
Operating Junction and Storage Temperature Range		$T_{J}, T_{STG}$	- 55 to +150	°C	

THERMAL PERFORMANCE					
PARAMETER	SYMBOL	LIMIT	UNIT		
Junction to Case Thermal Resistance	R <sub>eJC</sub>	3.2	°C/W		
Junction to Ambient Thermal Resistance	R <sub>OJA</sub>	53	°C/W		

**Thermal Performance Note:**  $R_{\Theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins.  $R_{\Theta JA}$  is guaranteed by design while  $R_{\Theta CA}$  is determined by the user's board design.

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PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV <sub>DSS</sub>	30			V
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	$V_{GS(TH)}$	1.2	1.6	2.5	V
Gate-Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	I <sub>GSS</sub>			±100	nA
	$V_{GS} = 0V, V_{DS} = 30V$	I <sub>DSS</sub>			1	μA
Drain-Source Leakage Current	$V_{GS} = 0V, V_{DS} = 30V$ $T_{J} = 125^{\circ}C$				100	
Drain-Source On-State Resistance	$V_{GS} = 10V, I_D = 19A$	_		3	3.8	mΩ
(Note 3)	$V_{GS} = 4.5V, I_D = 16A$	R <sub>DS(on)</sub>		4	5.5	
Forward Transconductance (Note 3)	$V_{DS} = 5V, I_{D} = 19A$	g <sub>fs</sub>		48		S
Dynamic (Note 4)						
Total Gate Charge	$V_{GS} = 10V, V_{DS} = 15V,$ $I_{D} = 19A$	$Q_g$		48		
Total Gate Charge	V <sub>GS</sub> = 4.5V, V <sub>DS</sub> = 15V,	$Q_g$		24		nC
Gate-Source Charge		$Q_{gs}$		6.9		
Gate-Drain Charge	I <sub>D</sub> = 16A	$Q_{gd}$		11		
Input Capacitance		C <sub>iss</sub>		2557		
Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V$	C <sub>oss</sub>		380		pF
Reverse Transfer Capacitance	f = 1.0MHz	C <sub>rss</sub>		276		
Gate Resistance	f = 1.0MHz	$R_g$	0.5	1.5	3	Ω
Switching (Note 4)						
Turn-On Delay Time		t <sub>d(on)</sub>		11		
Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 15V,$ $I_{D} = 19A, R_{G} = 2\Omega,$	t <sub>r</sub>		80		
Turn-Off Delay Time		t <sub>d(off)</sub>		33		ns
Turn-Off Fall Time		t <sub>f</sub>		65		
Source-Drain Diode						
Forward Voltage (Note 3)	V <sub>GS</sub> = 0V, I <sub>S</sub> = 19A	V <sub>SD</sub>			1	V
Reverse Recovery Time	I <sub>S</sub> = 19A ,	t <sub>rr</sub>		33		ns
Reverse Recovery Charge	dl/dt = 100A/µs	Q <sub>rr</sub>		19		nC

## Notes:

- 1. Silicon limited current only.
- 2. L = 0.3mH,  $V_{GS} = 10$ V,  $V_{DD} = 25$ V,  $R_G = 25\Omega$ ,  $I_{AS} = 26$ A, Starting  $T_J = 25$ °C
- 3. Pulse test: Pulse Width  $\leq$  300 $\mu$ s, duty cycle  $\leq$  2%.
- 4. Switching time is essentially independent of operating temperature.

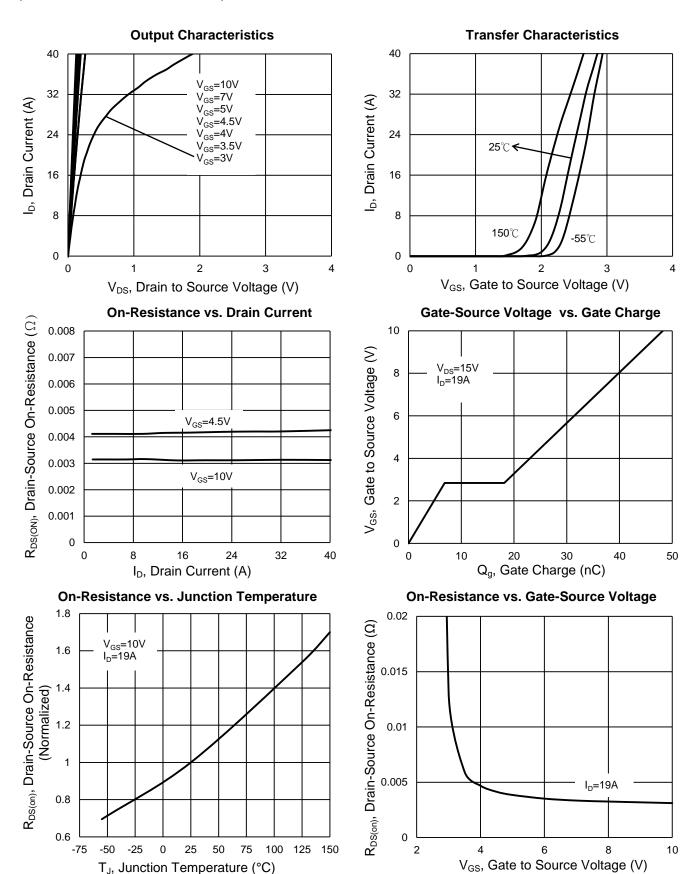
# **ORDERING INFORMATION**

PART NO.	PACKAGE	PACKING
TSM038N03PQ33 RGG	PDFN33	5,000pcs / 13" Reel



## **CHARACTERISTICS CURVES**

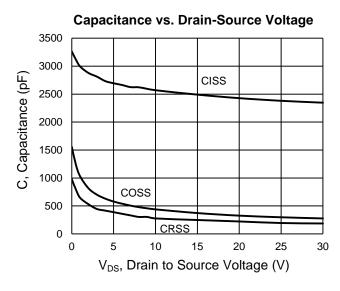
 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$ 

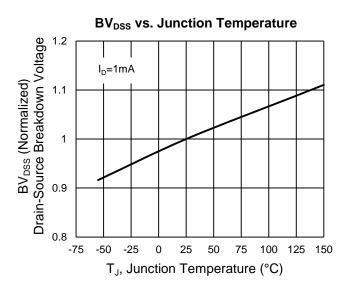




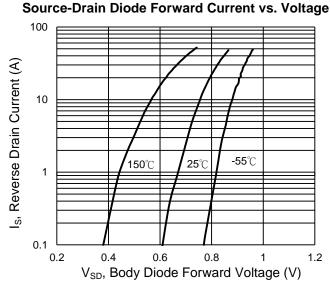
# **CHARACTERISTICS CURVES**

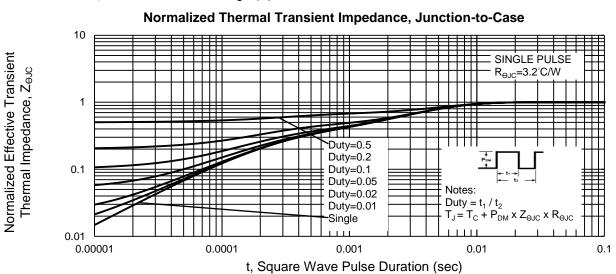
 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$ 





# Maximum Safe Operating Area, Junction-to-Case 1000 R<sub>DS(ON)</sub> 100 SINGLE PULSE R<sub>e,JC</sub>=3.2°C/W T<sub>C</sub>=25°C 100ms V<sub>DS</sub>, Drain to Source Voltage (V)





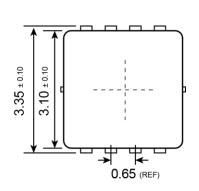
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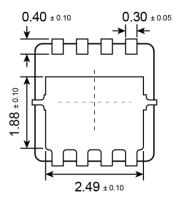


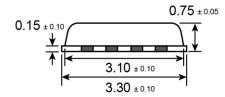


# PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)

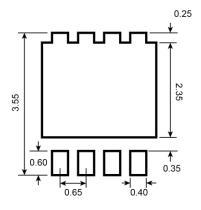
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# SUGGESTED PAD LAYOUT (Unit: Millimeters)



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# **MARKING DIAGRAM**



$$S = May \quad T = Jun \quad U = Jul \quad V = Aug$$

$$W = Sep \quad X = Oct \quad Y = Nov \quad Z = Dec$$

L = Lot Code (1~9, A~Z)



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